November 2001

IRFW710B / IRFI710B



IRFW710B / IRFI710B 400V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supplies and electronic lamp ballasts based on half bridge.

Features

- + 2.0A, 400V, $R_{DS(on)}$ = 3.4 Ω @V_{GS} = 10 V + Low gate charge (typical 7.7 nC)
- Low Crss (typical 6.0 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings T_c = 25°C unless otherwise noted

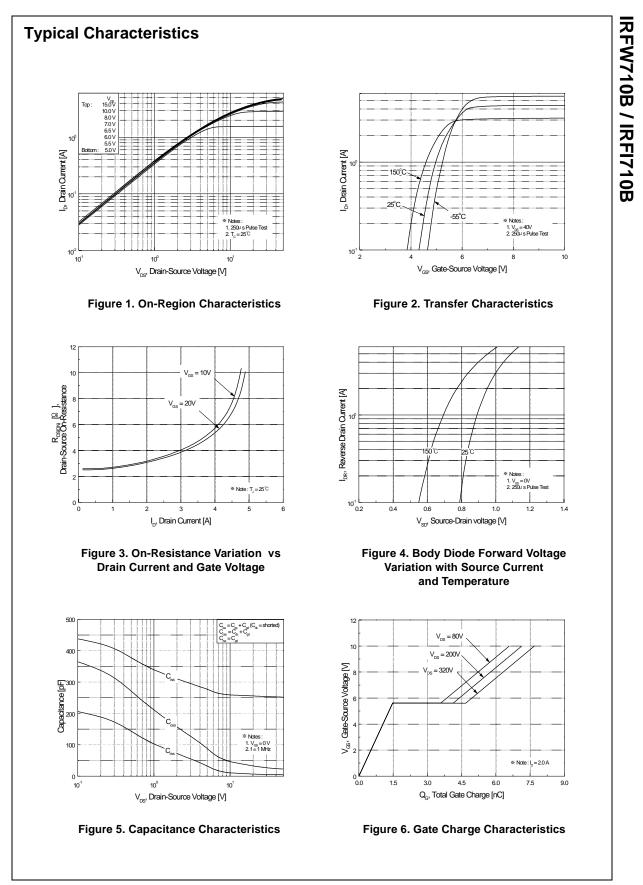
Symbol	Parameter		IRFW710B / IRFI710B	Units
V _{DSS}	Drain-Source Voltage		400	V
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$) - Continuous ($T_C = 100^{\circ}C$)		2.0	А
			1.3	А
I _{DM}	Drain Current - Pulsed	(Note 1)	6.0	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	100	mJ
I _{AR}	Avalanche Current	(Note 1)	2.0	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	3.6	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns
P _D	Power Dissipation ($T_A = 25^{\circ}C$) *Power Dissipation ($T_C = 25^{\circ}C$)- Derate above $25^{\circ}C$		3.13	W
			36	W
			0.29	W/°C
T _J , T _{stg}	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering pur 1/8" from case for 5 seconds	ooses,	300	°C

Thermal Characteristics

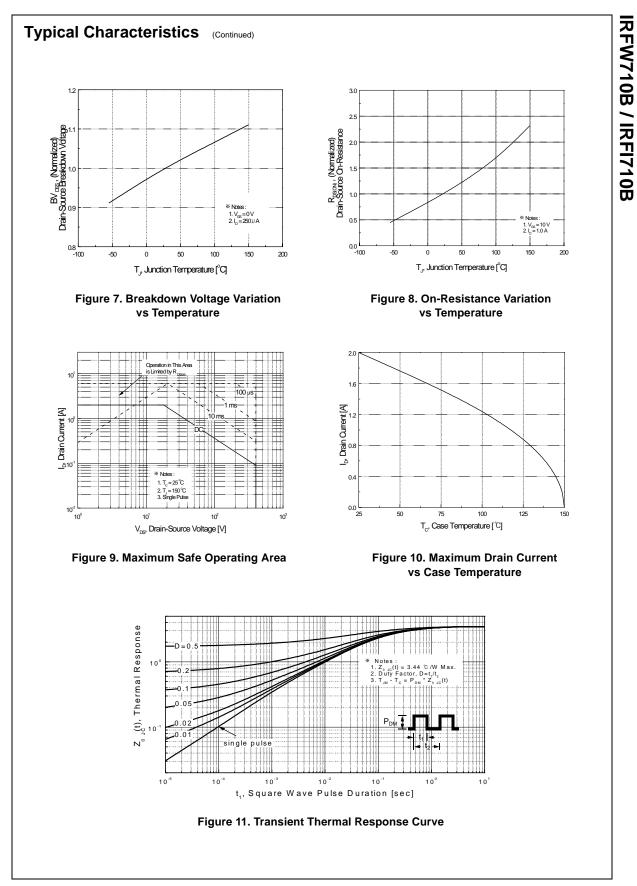
Symbol	Parameter	Тур	Max	Units
R _{θJC}	Thermal Resistance, Junction-to-Case		3.44	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient *		40	°C/W
R _{0JA}	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

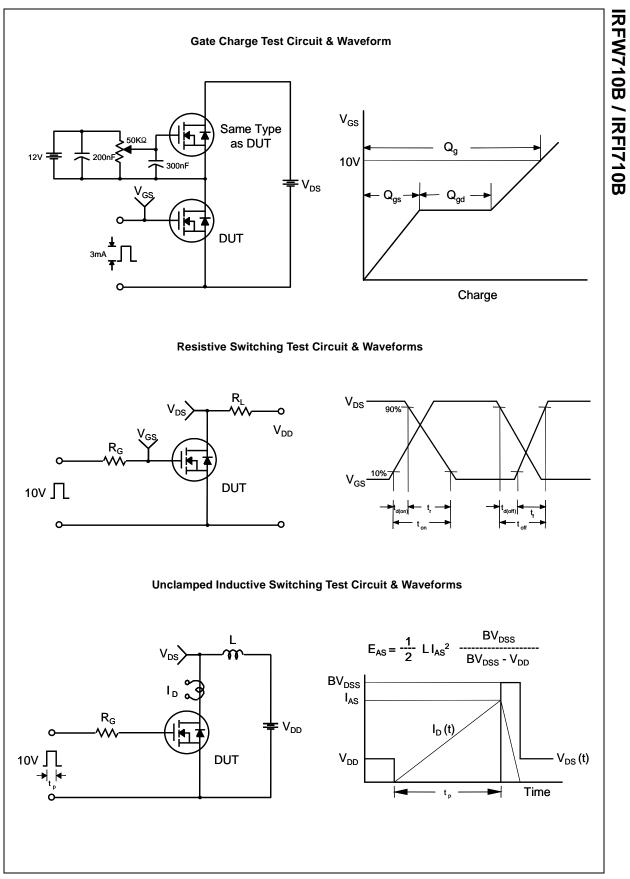
Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
Off Cha	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA		400			V
ΔBV _{DSS} / ΔT _{.1}	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}, \text{Referenced}$	to 25°C		0.4		V/°C
I _{DSS}	Zaro Cata Valtaga Drain Current	V _{DS} = 400 V, V _{GS} = 0 V				10	μA
	Zero Gate Voltage Drain Current	V _{DS} = 320 V, T _C = 125°C				100	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$				100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -30 V, V_{DS} = 0 V				-100	nA
On Cha	racteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA		2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 1.0 \text{ A}$			2.7	3.4	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 1.0 A	(Note 4)		2.2		S
				I			
•	ic Characteristics	1			250	220	~_
C _{iss}	Input Capacitance Output Capacitance	$V_{DS} = 25 V, V_{GS} = 0 V,$			250	330	pF
C _{oss} C _{rss}	Reverse Transfer Capacitance	f = 1.0 MHz			30 6.0	40 8.0	pF pF
	ng Characteristics Turn-On Delay Time Turn-On Rise Time	V _{DD} = 200 V, I _D = 2.0 A,			6.0 25	20 60	ns
t _{d(on)}	Turn-On Delay Time	Vpp = 200 V. lp = 2.0 A.			6.0	20	ns
	Turn-Off Delay Time	R _G = 25 Ω			20	50	ns
t _{d(off)} t _f	Turn-Off Fall Time	-	(Note 4, 5)		20	60	ns
Կ Q _g					7.7		ns
	Total Gate Charge	$V_{DS} = 320 \text{ V}, \text{ I}_{D} = 2.0 \text{ A},$				10	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V	(Note 4, 5)		1.5		nC
Q _{gd}	Gate-Drain Charge				3.2		nC
	ource Diode Characteristics an Maximum Continuous Drain-Source Dio		5			2.0	۸
l _S	Maximum Pulsed Drain-Source Diode F					6.0	A
I _{SM} Vor	Drain-Source Diode Forward Voltage					6.0 1.5	A V
V _{SD} t _{rr}	Reverse Recovery Time	$V_{GS} = 0 V, I_S = 2.0 A$ $V_{GS} = 0 V, I_S = 2.0 A,$			210	1.5	
			(Note 4)				ns
$\begin{array}{l} \text{L}=44\text{mH},\text{I},\\ \text{I}_{\text{SD}}\leq2.0\text{A},\\ \text{Pulse Test}: \end{array}$	Reverse Recovery Charge ating : Pulse width limited by maximum junction temper $_{S} = 2.0A$, $V_{DD} = 50V$, $R_{G} = 25 \Omega$, Starting $T_{J} = 25^{\circ}C$ di/dt $\leq 300A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting $T_{J} = 25^{\circ}C$ Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$ independent of operating temperature	dI _F / dt = 100 A/μs	(Note 4)		0.9		μC

IRFW710B / IRFI710B

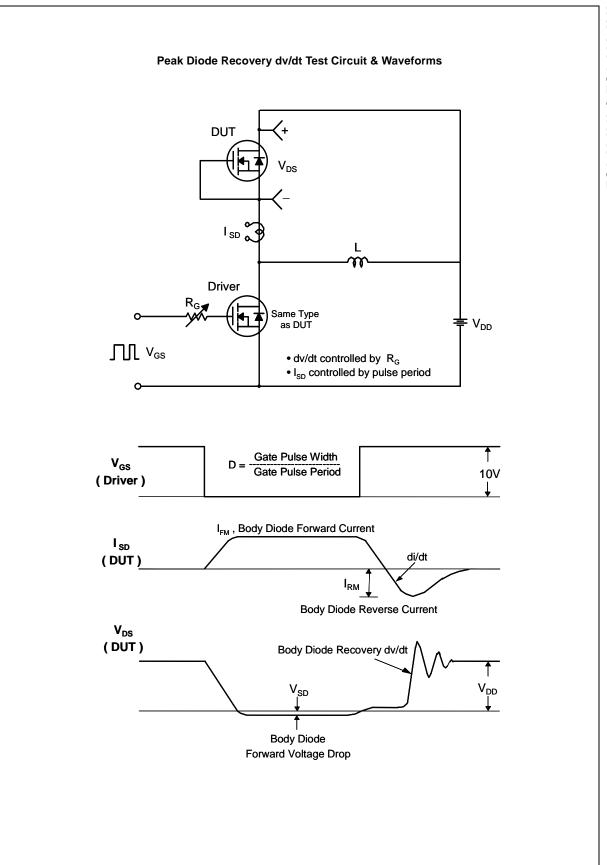


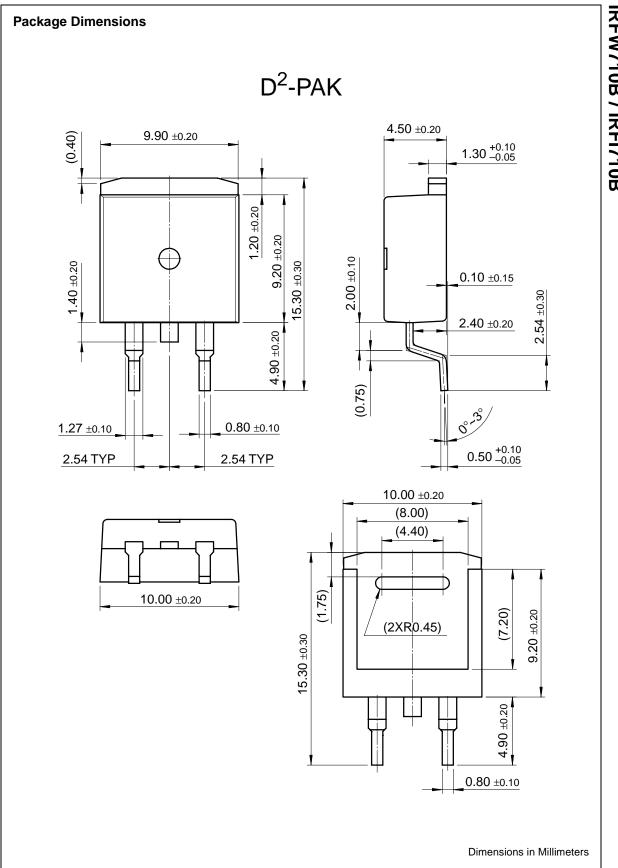
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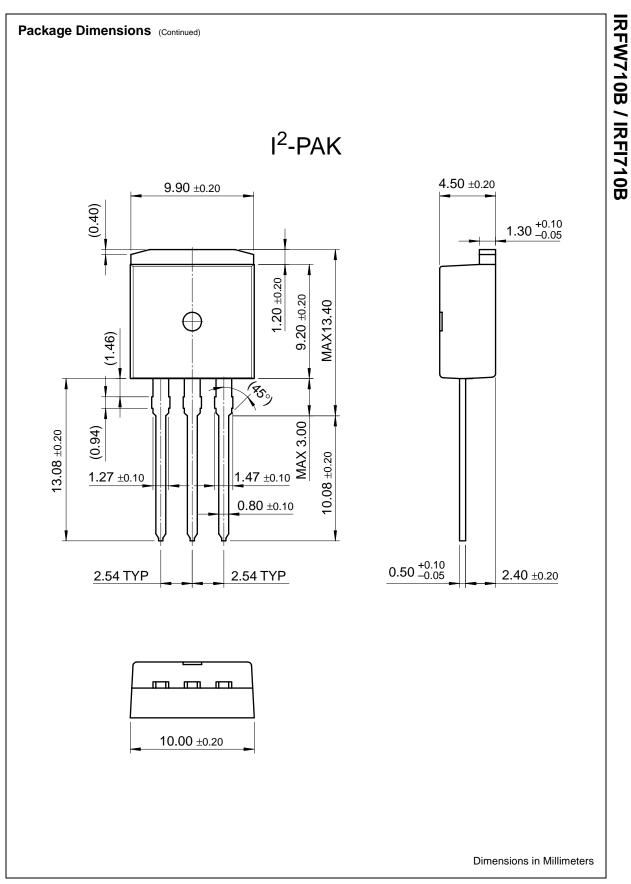




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PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
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Product selection and	field effect transistors are produced using Fairchild's proprietary, planar, DMOS	This pagePrint version	Dotted line
parametric search	technology.		Design tools
Cross-reference			
search	This advanced technology has been especially tailored to minimize on-state resistance,		
technical information	provide superior switching performance, and		
	withstand high energy pulse in the avalanche		
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technical support	suited for high efficiency switch mode power supplies and electronic lamp ballasts based on	-	
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company			
<u>_</u>	back to top		
	Features		

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10V

• Fast switching

Product status/pricing/packaging

• 2.0A, 400V, $R_{DS(on)} = 3.4\Omega @V_{GS} =$

• Low gate charge (typical 7.7 nC)

• Low Crss (typical 6.0 pF)

100% avalanche testedImproved dv/dt capability

ProductProduct statusPricing*Package typeLeadsPacking method
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IRFW710BTM	Full Production	\$0.52	TO-263(D2PAK)	2	TAPE REEL
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<u>Memory</u> <u>Optoelectronics</u> <u>Markets and</u> opplications	General description	<u>e-mail this datasheet</u> [E-	Dotted line Distributor and field sales representatives
applications New products Product selection and parametric search Cross-reference	These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar, DMOS technology.	This page <u>Print version</u>	Quality and reliability Dotted line Design tools
search technical information	This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche		
buy products	and commutation mode. These devices are well		
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	Features		

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Product status/pricing/packaging

Γ	Product	Product status	Pricing*	Package type	Leads	Packing method

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